Freeform Search

Database:

> US Pre-Grant Publication Full-Text Database
> US Patents Full-Text Database
> US OCR Full-Text Database
> EPO Abstracts Database
> JPO Abstracts Database
> Derwent World Patents Index
> IBM Technical Disclosure Bulletins

Term:

Display: 10 Documents in **Display Format:** - Starting with Number 1

Generate: ○ Hit List ◉ Hit Count ○ Side by Side ○ Image

[Search]   [Clear]   [Interrupt]

Search History

DATE: Thursday, April 06, 2006   Printable Copy   Create Case

Set Name side by side	Query	Hit Count	Set Name result set
DB=PGPB,USPT; PLUR=YES; OP=ADJ			
L5	L4 and l1	11	L5
L4	L3 or l2	1043	L4
L3	((portion or section or part) near4 read) with (compar$6 or match$3 or different or colli$4 or conflict$3 or identical or correspond$3) with write	956	L3
L2	(((identical or lower or higher or upper or odd or even or significant)adj2 bit) near6 read) with (compar$6 or match$3 or different or colli$4 or conflict$3 or identical or correspond$3) with write	128	L2
L1	711/150.ccls.	607	L1

END OF SEARCH HISTORY

IEEE Xplore®
RELEASE 2.1

Search Session History

BROWSE   SEARCH   IEEE XPLORE GUIDE

Edit an existing query or compose a new query in the Search Query Display.

Thu, 6 Apr 2006, 2:01:38 PM EST

Search Query Display

Select a search number (#) to:

- Add a query to the Search Query Display
- Combine search queries using AND, OR, or NOT
- Delete a search
- Run a search

Recent Search Queries

#1   (((((portion or section or part) <near/4> read) <sentence> (compar$ or match$ or different or colli$ or conflict$ or identical or correspond$) <sentence> write)<in>metadata)

#2   (((((portion or section or part) <near/4> read) <sentence> (compar$ or match$ or different or colli$ or conflict$ or identical or correspond$) <sentence> write)<in>metadata)

#3   ((((((identical or lower or higher or upper or odd or even or significant)<near/2> bit) <near/6> read) <sentence> (compar$ or match$ or different or colli$ or conflict$ or identical or correspond$) <sentence> write)<in>metadata)

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